

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SLATTER ET AL.	
		Examiner Lin Ye	Art Unit 2615	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,912,653	06-1999	Fitch, Stephan J.	345/87
	B	US-4,965,705	10-1990	Lin, Wen-Tsung	362/103
	C	US-6,667,771	12-2003	Kweon, Sup Heuk	348/373
	D	US-3,141,216	07-1964	HASKELL ELIZABETH W	24/303
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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